





West et al.

Docket No.: TI-36238

Serial No.: 10/697,137 Examiner: Guerrero, M.

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Art Unit: Conf. No.:

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Title: METHOD FOR IMPROVING RELIABILITY OF COPPER INTERCONNECTS

TRANSMITTAL OF FORMAL DRAWINGS

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

Attn: Official Draftsperson

Dear Sir:

MAILING CERTIFICATE UNDER 37 C.F.R. §1.8(A)

I hereby certify that the above correspondence is being deposited with the U.S. Postal Service as First Class Mail in an envelope addressed to: Commissioner of Patents, P. O. Box 1450, Alexandria, VA 22313-1450.

Date₂

Marianna Smith

Submitted herewith are three (3) sheets of formal drawings.

Charge any necessary fee to Deposit Account No. 20-0668. The original and a copy of this authorization are enclosed.

Respectfully submitted,

Texas Instruments Incorporated P. O. Box 655474, MS 3999 Dallas, Texas 75265 (214) 532-9348

Fax: (972) 917-4418 or (972) 917-4417 Jacqueline J. Garner Attorney for Applicants

Reg. No.: 36,144